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<u>L25</u>	(kaizen) and (dmaic)	2	<u>L25</u>
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<u>L22</u>	(integrat\$3 adj3 six adj sigma) and (kaizen)	0	<u>L22</u>
<u>L21</u>	(six adj sigma) and (kaizen adj3 analyz\$5)	0	<u>L21</u>
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<u>L18</u>	(six sigma kaizen schedule)	933703	<u>L18</u>
<u>L17</u>	(six sigma kaizen)	847773	<u>L17</u>
<u>L16</u>	(six adj sigma adj kaizen adj3 schedul\$3) and (kaizen)	0	<u>L16</u>
<u>L15</u>	(six adj sigma) and (kaizen adj analysis)	0	<u>L15</u>
<u>L14</u>	(six adj sigma) and (lean adj manufactur\$3) and (kaizen adj analysis)	0	<u>L14</u>
<u>L13</u>	(integrat\$4 adj3 six adj sigma) and (lean adj manufact\$3) and (kaizen adj analysis)	0	<u>L13</u>

<u>L12</u>	(level adj indicator) and (integrat\$4 adj3 six adj sigma) and (lean adj manufact\$3) and (kaizen adj analysis)	0	<u>L12</u>
<u>L11</u>	(integrat\$4 adj3 six adj sigma) and (lean adj manufactur\$3) and (kaizen adj analysis)	0	<u>L11</u>
<u>L10</u>	(integration adj3 six adj sigma) and (lean adj manufacturing) and (kaizen adj analysis)	0	<u>L10</u>
<u>L9</u>	(integration adj six adj sigma) and (lean adj manufacturing) and (kaizen adj analysis)	0	<u>L9</u>
<u>L8</u>	(analyz\$6 adj3 problem adj statement) and (level adj indicator) ann (integrat\$4 adj3 six adj sigma) and (lean adj manufact\$3) and (kaizen adj analysis)	138004	<u>L8</u>
<u>L7</u>	(analyz\$6 adj3 problem adj statement) and (level adj indicator) ann (integrat\$4 adj3 six adj sigma) and (lean adj manufact\$3) and (kaizen)	138004	<u>L7</u>
<u>L6</u>	schweizehorf.inv.	0	<u>L6</u>
<u>L5</u>	schweizehorf-e.inv.	0	<u>L5</u>
<u>L4</u>	mcrae.inv.	916	<u>L4</u>
<u>L3</u>	mcrae-k.inv.	0	<u>L3</u>
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Volume 1, 18-21 Oct. 2004 Page(s):1 - 5 Vol.1

[AbstractPlus](#) | Full Text: [PDF](#)(626 KB) IEEE CNF
**2. Inventory management Kaizen**

Palmer, V.S.;  
Engineering Management for Applied Technology, 2001. EMAT 2001. Proceedings. 2n  
Workshop on  
16-17 Aug. 2001 Page(s):55 - 56

[AbstractPlus](#) | Full Text: [PDF](#)(274 KB) IEEE CNF
**3. Lean Sigma [production and supply chain management]**

Antony, J.; Escamilla, J.L.; Caine, P.;  
Manufacturing Engineer  
Volume 82, Issue 2, April 2003 Page(s):40 - 42

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**4. Modelling of an integrated quality system using IDEFO**

Rowlands, H.; Richards, C.;  
Industrial Electronics, 2002. ISIE 2002. Proceedings of the 2002 IEEE International Sy  
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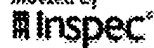
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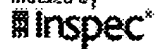
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